Se	arc	:h	No	tes	•	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/774,976	BELCHER, WAYNE
Examiner	Art Unit
Emmanuel S. Luk	1722

SEARCHED				
Class	Subclass	Date	Examiner	
425	458	4/29/2006	EL	
[.] 15	105.5	4/29/2006	EL	
15	236.01	4/29/2006	EL	
15	236.07	4/29/2006	EL	
	,			
		×		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		`		
_ · ·				
	<u> </u>			

SEARCH N (INCLUDING SEARC)
	DATE	EXMR
EAST text search	4/29/2006	EL
updated EAST text search	10/2/2006	EL
·		
•		
•		